

Search Notes

Application/Control No.

10/061,721

Examiner

Jung Park

Applicant(s)/Patent under
Reexamination

KHILL, UZI

Art Unit

2661

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Chau Nguyen, Christian Laforgia, & Andrew Caldwell 370/401-404, 707/1 (text search only - see histroy printout	12/27/2005	JP
EAST (USPT, US_PGPUB) - See Search History Printout	12/27/2005	JP
Internet Search for IEEE Standard	12/27/2005	JP